AMENDMENTS TO THE CLAIMS:

Please cancel Claims 11 and 12-26, amend Claims 1 and 10 and add new Claims 27-30 as follows:

1. (Amended) An ultrasonic transducer, comprising:

an ultrasonic sensor having a plurality of <u>transducer</u> elements <u>formed on a first</u> wafer component; and

an integrated circuit formed on a <u>second</u> wafer <u>component</u>, the <u>said second</u> wafer <u>component</u> including a plurality of cavities defining a plurality of posts such that the cavities <u>are configured and dimensioned to</u> alter the acoustic impedance of <u>the said second</u> wafer <u>component in a predefined manner</u>, and wherein the integrated circuit is joined to the ultrasonic sensor <u>on said first wafer component</u> and wherein each of the elements of the ultrasonic sensor is located over <u>one of a respective one of the plurality of posts and</u> a respective one of the plurality of cavities.

- 2. (Original) The transducer of claim 1, wherein the ultrasonic sensor comprises piezoelectric ceramic material.
- 3. (Original) The transducer of claim 1, wherein the ultrasonic sensor comprises a micro-machined ultrasonic transducer (MUT).
 - 4. (Previously Canceled)
 - 5. (Previously Canceled)
- 6. (Original) The transducer of claim 1, wherein the cavities reduce acoustic energy traveling laterally in the wafer.

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- 7. (Original) The transducer of claim 1, wherein the wafer is silicon.
- 8. (Original) The transducer of claim 1, wherein the wafer is germanium.
- 9. (Original) The transducer of claim 1, wherein the cavities are designed to allow the acoustic impedance of the wafer to match the acoustic impedance of the transducer elements.
- 10. (Amended) The transducer of claim 1, wherein the cavities are configured and dimensioned in a predetermined manner for the purpose of altering the acoustic impedance of the wafer to increase the effective bandwidth of the transducer elements.
 - 11. (Canceled) The transducer of claim 1, wherein the wafer further comprises:
 a first wafer component including the plurality of cavities; and
 a second wafer component bonded to the first wafer component.
 - 12-26. (Canceled)
 - 27. (New) An ultrasonic transducer, comprising:

an ultrasonic sensor having a plurality of transducer elements formed on a first wafer component; and

an integrated circuit formed on a second wafer component, said second wafer component including a plurality of cavities containing one of a vacuum and a gas defining a plurality of posts such that said cavities are configured and dimensioned to alter the acoustic impedance of said second wafer component in a predefined manner, and wherein said integrated circuit is joined to said first wafer component and wherein each said transducer element is located over one of a respective one of said plurality of posts and a respective one of said plurality of cavities.

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- 28. (New) The transducer of claim 27, wherein said plurality of transducer elements are selected from the group consisting of: a piezoelectric ceramic material and a micro-machined ultrasonic transducer (MUT).
- 29. (New) The transducer of claim 27, wherein the cavities are designed to allow the acoustic impedance of the wafer to match the acoustic impedance of the transducer elements.
- 30. (New) The transducer of claim 27, wherein the cavities are configured and dimensioned in a predetermined manner for the purpose of altering the acoustic impedance of the wafer to increase the effective bandwidth of the transducer elements.